



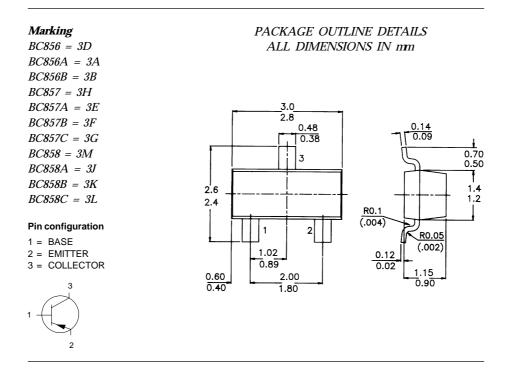
SOT-23 Formed SMD Package

BC856 BC857 BC858

SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistors

An ISO/TS 16949, ISO 9001 and ISO 14001 Certified Company



ABSOLUTE MAXIMUM RATINGS

			BC856	BC857	BC83	58
Collector-emitter voltage (+ $V_{BE} = 1 V$)	$-V_{CEX}$	max.	80	50	30	V
Collector-emitter voltage (open base)	-V _{CE0}	max.	65	45	30	V
Collector current (peak value)	-I _{CM}	max.		200		mA
Total power dissipation						
$up to T_{amb} = 60 ^{\circ}C$	P_{tot}	max.		<i>250</i>		mW
Junction temperature	T_{j}	max.		<i>150</i>		$^{\circ}$ C
Small-signal current gain	J					
$-I_C = 2 \text{ mA}; -V_{CE} = 5 \text{ V}; f = 1 \text{ kHz}$	h_{fe}		7	'5 to 90	0	
Transition frequency at $f = 100 \text{ MHz}$						
$-I_C = 10 \text{ mA; } -V_{CE} = 5 \text{ V}$	f_T	>		100		$M\!H\!z$
Noise figure at $R_S = 2 \text{ kW}$						
$-I_C = 200 \text{ mA; } -V_{CE} = 5 \text{ V}$						
f = 1 kHz; B = 200 Hz	\boldsymbol{F}	<		10		dB

RATINGS (at $T_A = 25$ °C unless otherwise specified) Limiting values

Zamang values		i	BC856 BC857BC858			
Collector-base voltage (open emitter)	$-V_{CBO}$	max.	80	50	30	\overline{V}
Collector-emitter voltage $(+V_{BE} = 1 \ V)$	$-V_{CEX}$	max.	<i>80</i>	50	30	V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	65	45	30	V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	5	5	5	V
Collector current (d.c.)	$-I_C$	max.		100	l	mA
Collector current (peak value)	$-I_{CM}$	max.		200		mA
Emitter current (peak value)	I_{EM}	max.		200		mA
Base current (peak value)	$-I_{BM}$	max.		200		mA
Total power dissipation						
up to T_{amb} : 60 °C	P_{tot}	max.		<i>250</i>		mW
Storage temperature	T_{stg}		−55 to +150			${}^{\!$
Junction temperature	T_j	max.		150		${\mathscr C}$
THERMAL CHARACTERISTICS						
$T_j = P_X (R_{th j-t} + R_{th t-s} + R_{th s-a})^+ T_{amb}$ Thermal resistance						
From junction to tab	R_{thj-t}	=		60		KW
From tab to soldering points	$R_{th\ t-s}$	=		280		KW
From soldering points to ambient	R _{th s-a}	=		90		KW
0.1	ui s-a					
CHARACTERISTICS						
$T_j = 25$ °C unless otherwise specified						
Collector cut-off current						
$I_E = 0$; $-V_{CB} = 30V$; $T_i = 25^{\circ}C$	$-I_{CBO}$	typ.		1		nΑ
J		<		15		nA
$T_j = 150^{\circ} C$	-I _{CBO}	<		4		$\mathfrak{m}A$
Base-emitter voltage						
$-I_C = 2 \text{ mA; } -V_{CE} = 5 \text{ V}$	$-V_{BE}$	typ.		650		mV
IC Z III I, VCE UV	* DE	ijρ.	6	200 to 7.	50	mV
			U		<i>,</i>	
$-I_C = 10 \text{ mA; } -V_{CE} = 5 \text{ V}$	$-V_{BE}$	<		820		mV
Saturation voltages						
$-I_C = 10 \text{ mA}; -I_B = 0.5 \text{ mA}$	-V _{CEsat}	typ.		75		mV
, <u>b</u>	CLour	<		300		mV
	Vpr.			700		mV
	-V _{BEsat}	typ.		700		III V
$-I_C = 100 \text{ mA}; -I_B = 5 \text{ mA}$	-V _{CEsat}	typ.		250		mV
0 0	02541	<		650		mV
	-V _{BEsat}	typ.		850		mV
Knee voltage	DESAL	JF.				• •
$-I_C = 10 \text{ mA}$; $-I_B = \text{value for which}$						
$-I_C = 11 \text{ mA at } -V_{CE} = 1 \text{ V}$	-V _{CEK}	typ.		250		mV
10 - 11 mm i ac v CE - 1 v	CEK			600		mV
		<		000		111 V

BC856 BC857 BC858

Collector capacitance at $f = 1$ MHz			
$I_E = I_e = 0$; $-V_{CB} = 10 \ V$	C_c	typ.	4,5 pF
Transition frequency at $f = 100 \text{ MHz}$			
$-I_C = 10 \text{ mA; } -V_{CE} = 5 \text{ V}$	f_T	>	100 MHz
Small-signal current gain at $f = 1$ kHz			
$-I_C = 2 \text{ mA}; -V_{CE} = 5 \text{ V}$	$h_{f\!e}$	125 t	o 800
Noise figure at $R_S = 2 \text{ kW}$			
$-I_C = 200 \text{ mA}; -V_{CE} = 5 \text{ V}$			
f = 1 kHz; B = 200 Hz	F	typ.	2 dB
		<	10 dB
D.C. current gain			
$-I_C = 2 \text{ mA}; -V_{CE} = 5 \text{ V BC856}$	$h_{\!F\!E}$	220 t	o 475
BC858/857	$h_{\!F\!E}$	125 t	o 800
BC856A/857A/858A	$h_{\!F\!E}$	125 t	o 250
BC856B/857B/858B	$h_{\!F\!E}$	220 t	o 475
BC857C/858C	$h_{\!F\!E}$	420 t	o 800

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